

<b>Notice of References Cited</b>	Application/Control No. 10/575,158		Applicant(s)/Patent Under Reexamination CAMENISCH, JAN	
	Examiner SHIN-HON CHEN		Art Unit 2131	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0223007	10-2005	Zimmer et al.	707/009
*	B	US-7,165,181	01-2007	Brickell, Ernie F.	713/182
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
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**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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